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Date: Friday, August 19, 2005

To USPTO - Examiner: Kiet Tuan Ngo

Art Unit: 2195

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Sean P. McDermott From:

Customer No: 29855

Atty. Docket #: 149-0044U\$

Serial No.: 10/014,337

Re:

Please see the attached

Pages (including cover page): 24

Received in the United States Patent and Trademark Office

 Reply to Non-Final Office Action Dated May 20, 2005 and Amendment (24 pages).

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.

10/014,337

Confirmation No.: 1522

Applicant

Yiping Ding

Entitled

System and Method for Automatic Workload Characterization

Filed

12-01-2001

TC/A.U.

2195

Examiner

Kiet Tuan Ngo

Docket No.

149-0044US

Customer No.:

29855

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MAIL STOP AMENDMENT

Commissioner for Patents PO BOX 1450

Alexandria, VA 22313-1450

REPLY TO NON-FINAL OFFICE ACTION DATED 05/20/2005 AND AMENDMENT

In response to the Office Action of May 20, 2005, please amend the above-identified application as follows:

- Amendments to the Claims are reflected in the listing of claims, which begins on page 2 of this paper.
- II. Remarks In Response to the Office Action begin on page 15 of this paper.